



# ПРЕДУСИЛИТЕЛЬ СИГНАЛОВ С СИРМ С ФУНКЦИЕЙ ТОТ ДЛЯ ВВС



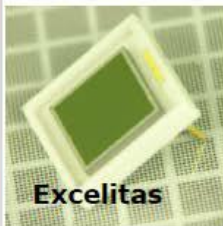
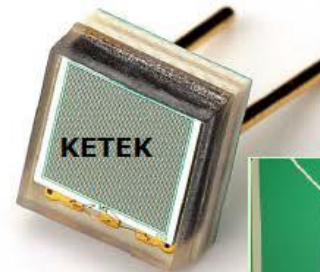
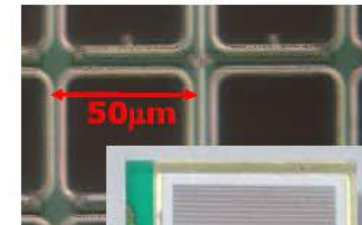
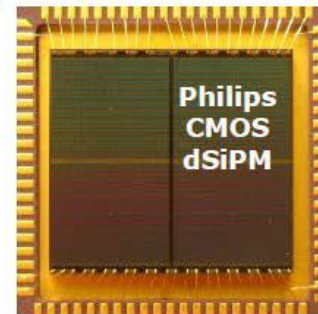
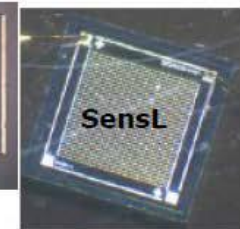
Дубна 16.12.2019

# SIPM история

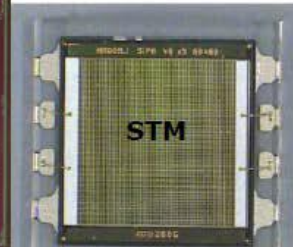
## Today

Many institutes/companies are involved in SiPM development/production:

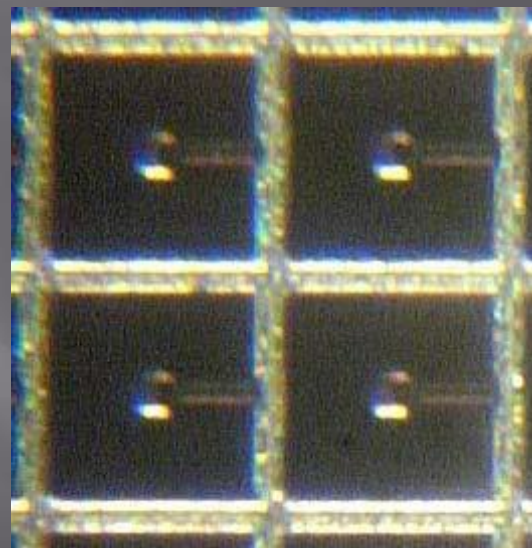
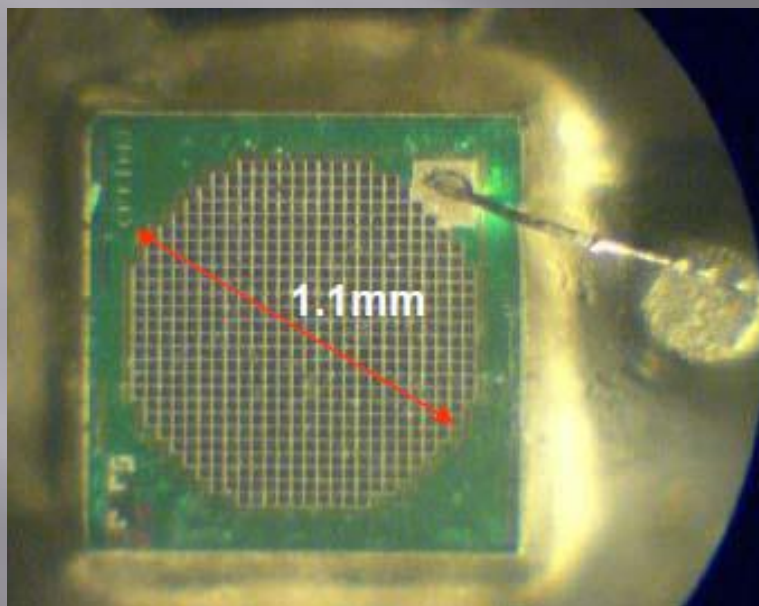
- **CPTA**, Moscow, Russia
- **MePhi/Pulsar** Enterprise, Moscow, Russia
- **Zecotek**, Vancouver, Canada
- **Hamamatsu HPK**, Hamamatsu, Japan
- **FBK-AdvanSiD**, Trento, Italy
- **ST Microelectronics**, Catania, Italy
- **Amplification Technologies** Orlando, USA
- **SensL**, Cork, Ireland
- **MPI-HLL**, Munich, Germany
- **RMD**, Boston, USA
- **Philips**, Aachen, Germany
- **Excelitas** tech. (formerly Perkin-Elmer)
- **KETEK**, Munich, Germany
- **National Nano Fab Center**, Korea
- **Novel Device Laboratory (NDL)**, Beijing, China
- **E2V**
- **CSEM**



Amplification Technologies (DAPD)

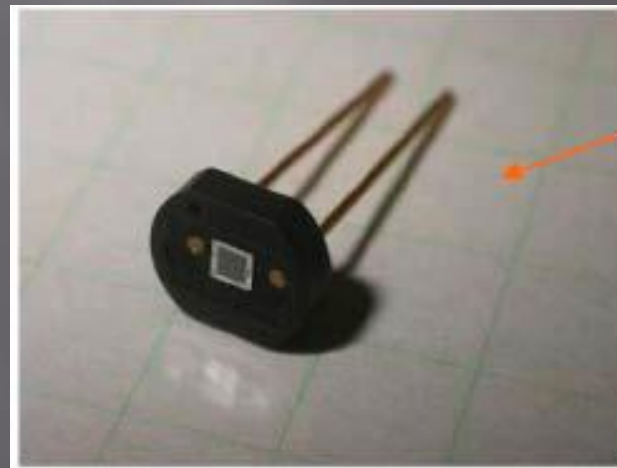
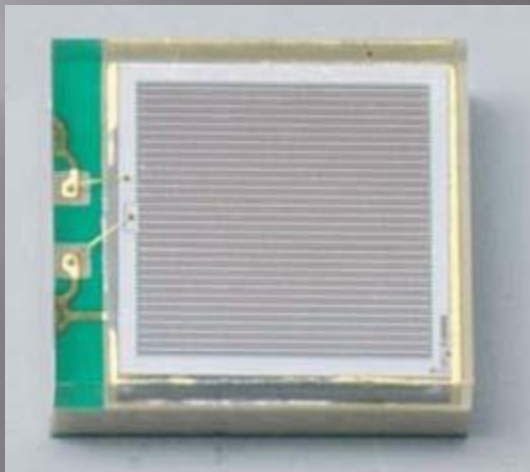


# SIPM история



## SIPM ЦПТА

# SIPM история



# SIPM реалии

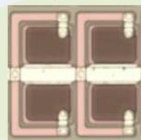
## KETEK Trench Technology with very low noise and improved timing

Most devices of the KETEK SiPM family will be available with the new trench technology:

- Optical crosstalk below 20% for encapsulated PM3350 at 20% overvoltage
- Dark count rates down to 200 kHz/mm<sup>2</sup>
- Excellent timing



15 μm



25 μm



50 μm



60 μm



75 μm



100 μm

K:\~ Buid\SIPM06 CERN01 Fotoshooting\60A1 - version 2 1.tif



**KETEK**

Creative Detector Solutions



ISO 9001:2008  
Certified

KETEK GmbH  
Hofer Str. 3  
81737 München - GERMANY  
TEL +49 89 673 46770  
FAX +49 89 673 46777  
www.ketek.net · info@ketek.net

# SIPM реалии

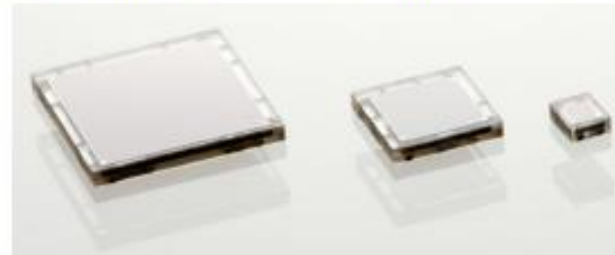
C-Series Low Noise, Fast, Blue-Sensitive Silicon Photomultipliers  
DATASHEET

sensl  
sense light

## Low Noise, Fast, Blue-Sensitive Silicon Photomultipliers

SensL's C-Series low-light sensors feature an industry-leading low dark-count rate, combined with high PDE that extends much further into the blue part of the spectrum using a high-volume, P-on-N silicon process. For ultrafast timing applications select C-Series sensors have a fast output, previously introduced in SensL's M-Series & B-Series sensors. These fast signals can have rise times of 300ps and pulse widths of 600ps. The C-Series is available in different sensor sizes (1mm, 3mm and 6mm) and packaged in a variety of formats, including a 4-side tileable surface mount (SMT) package that is compatible with industry standard, lead-free, reflow soldering processes. C-Series sensors are pin-for-pin compatible with the B-Series.

The C-Series Silicon Photomultipliers (SiPM) form a range of high gain, single-photon sensitive, UV to visible light sensors. They have performance characteristics similar to a conventional PMT, while benefiting from the practical advantages of solid-state technology: low operating voltage, excellent temperature stability, robustness, compactness, output uniformity, and low cost. For more information on the C-Series devices please refer to the website, [www.sensl.com](http://www.sensl.com).



# SIPM реалии

## PERFORMANCE PARAMETERS

Sensor Size	Microcell Size	Parameter <sup>1</sup>	Overtoltage	Min.	Typ.	Max.	Units
1mm	10μ, 20μ, 35μ, 50μ	Breakdown Voltage ( $V_{br}$ ) <sup>3</sup>		24.2		24.7	V
3mm	20μ, 35μ, 50μ						
6mm	35μ						
1mm	10μ, 20μ, 35μ, 50μ	Recommended overtoltage Range (Voltage above $V_{br}$ ) <sup>2</sup>		1.0		5.0	V
3mm	20μ, 35μ, 50μ						
6mm	35μ						
1mm	10μ, 20μ, 35μ, 50μ	Spectral Range <sup>4</sup>		300		800	nm
3mm	20μ, 35μ, 50μ						
6mm	35μ						
1mm	10μ, 20μ, 35μ, 50μ	Peak Wavelength ( $\lambda_p$ )			420		nm
3mm	20μ, 35μ, 50μ						
6mm	35μ						

<sup>1</sup> All measurements made at 2.5V overtoltage and 21°C unless otherwise stated.

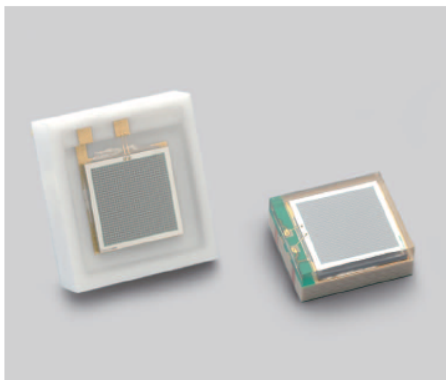
<sup>2</sup> Please consult the maximum current levels on page 6 when selecting the overtoltage to apply.

<sup>3</sup> The breakdown voltage ( $V_{br}$ ) is defined as the value of the voltage intercept of a parabolic line fit to the current vs. voltage characteristic curve.

<sup>4</sup> SMT package spectral range is limited from 320nm to 800nm. X13 package extends UV response to 300nm.

# SIPM реалии

**HAMAMATSU**  
PHOTON IS OUR BUSINESS



## MPPC® (multi-pixel photon counter)

S12572-010, -015C/P

**Low afterpulse, wide dynamic range,  
for high-speed measurement**  
**Photosensitive area: 3 × 3 mm**

These MPPCs utilize very small pixels arrayed at high densities to achieve a high-speed recovery time and wide dynamic range. Hamamatsu currently produces MPPC with a pixel density up to 10000 pixels/mm<sup>2</sup> (pixel pitch: 10 μm). Utilizing advanced technology to enhance photon detection efficiency minimizes the drop in photon detection efficiency that usually occurs due to shrinking the pixel pitch.

### ❖ Features

- ➔ Low afterpulse
- ➔ High fill factor
- ➔ High photon detection efficiency
- ➔ Wide operating voltage range
- ➔ Short recovery time
- ➔ High count rate

### ❖ Applications

- ➔ Scintillation measurement
- ➔ Low-light-level detection
- ➔ Scattered light measurement

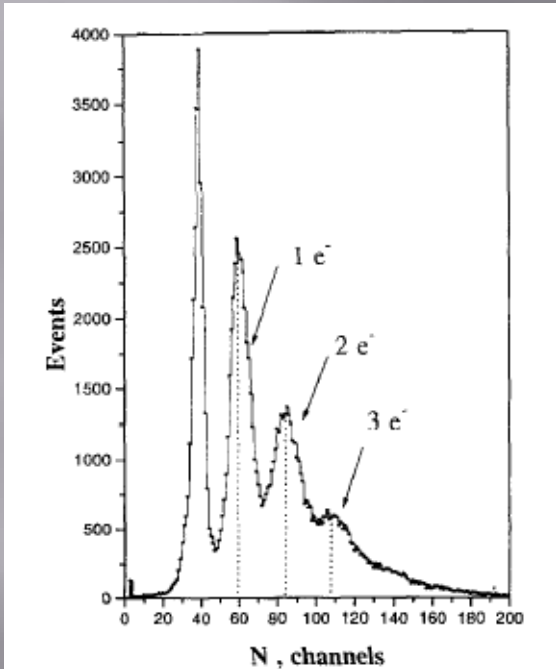
### ❖ Related product (sold separately)

➔ MPPC module

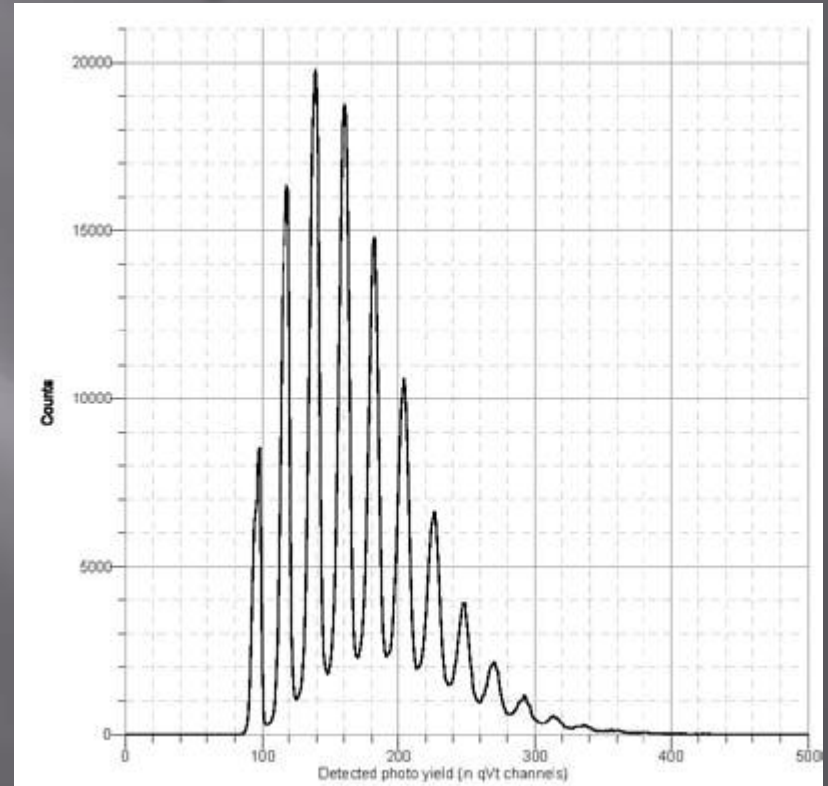
C11209-110



# SIPM история

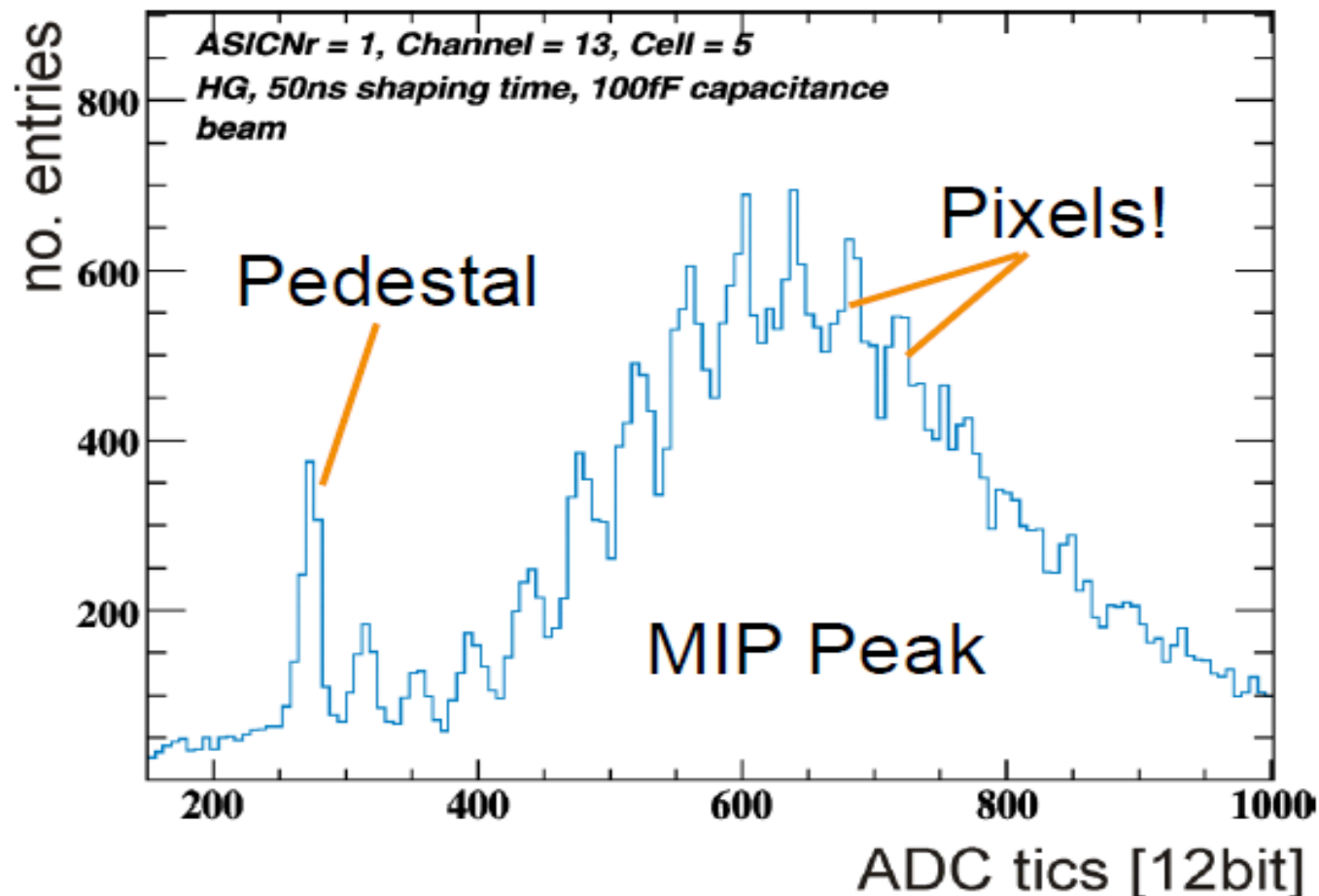


(A. Akindinov et al., NIM387 (1997)  
231)



Barry W. Baumbaugh, et al. 2009 IEEE  
Nuclear Science Symposium Conference  
Record  
(0.25pC/channel)

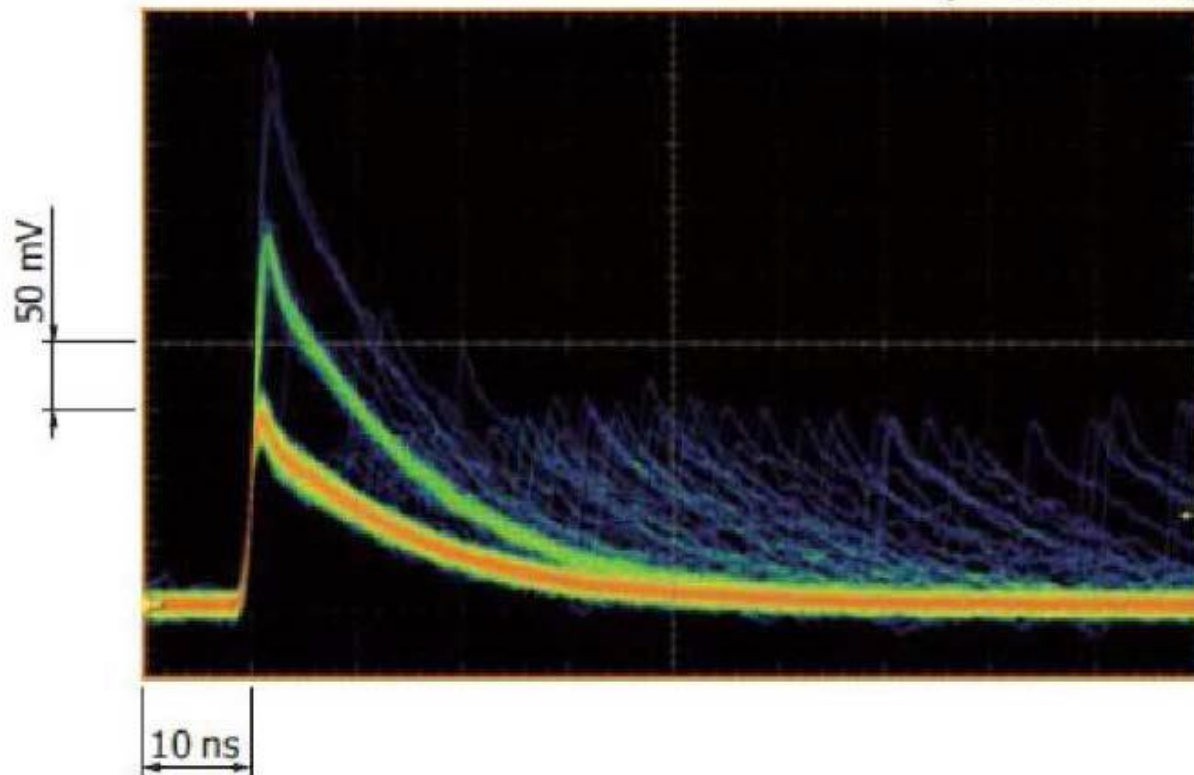
# MIP response in DESY 6 GeV electron testbeam



# SIPM сигналы

(a) S10362-11-050C (previous product)

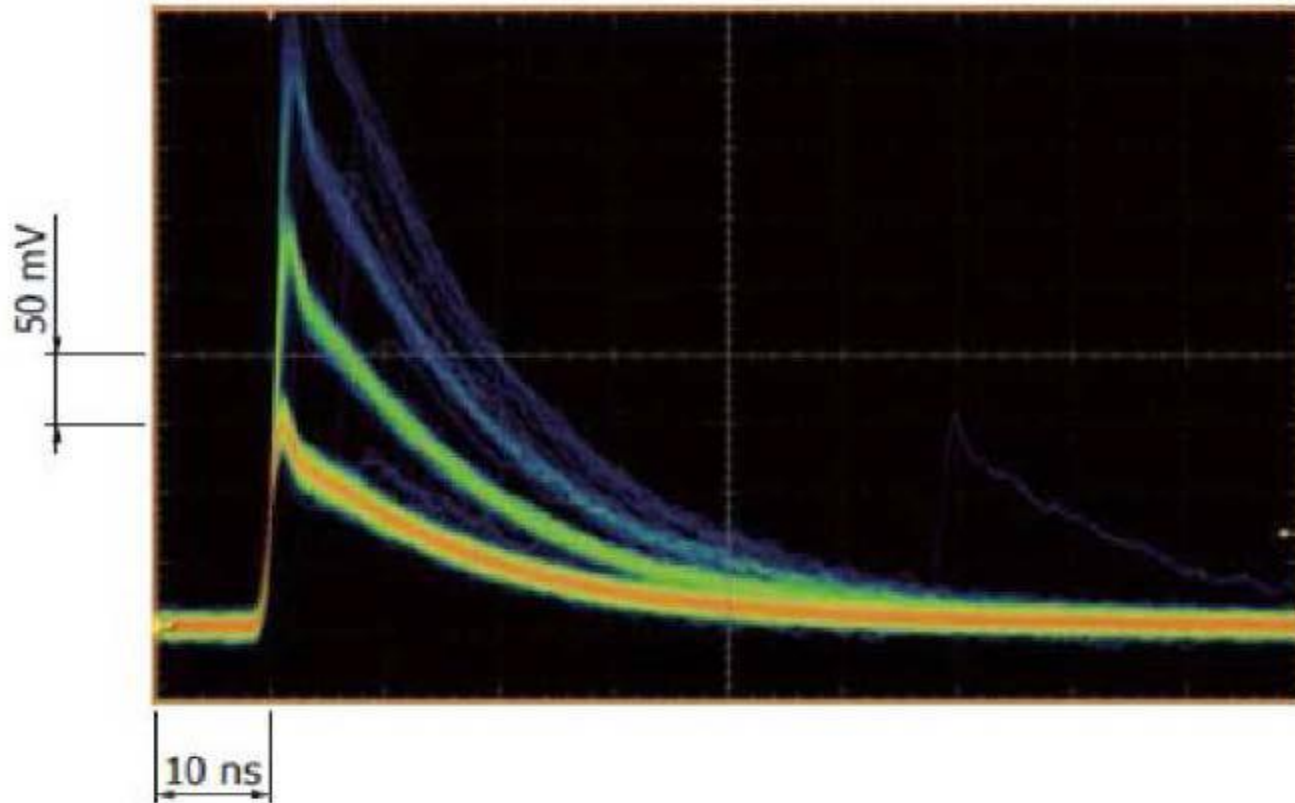
( $M=1.25 \times 10^6$ )



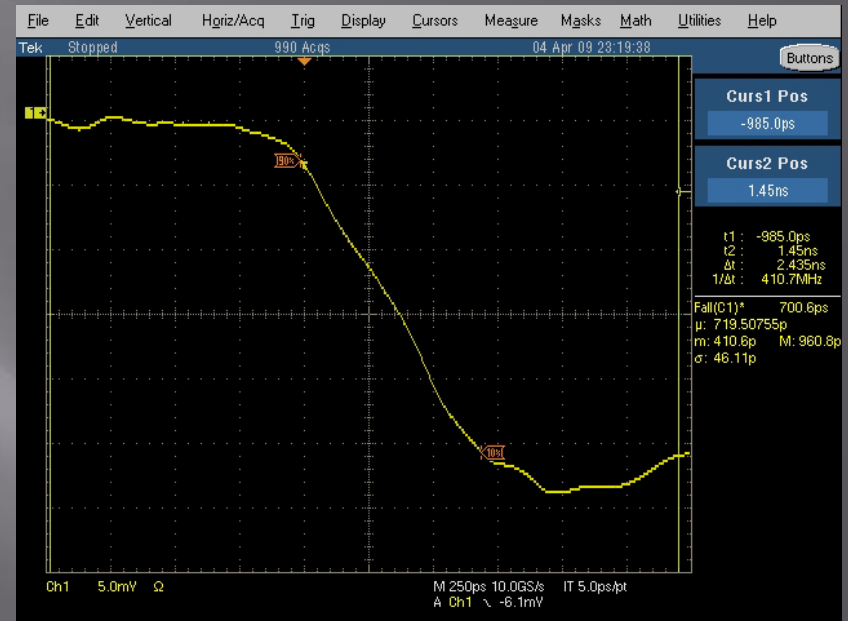
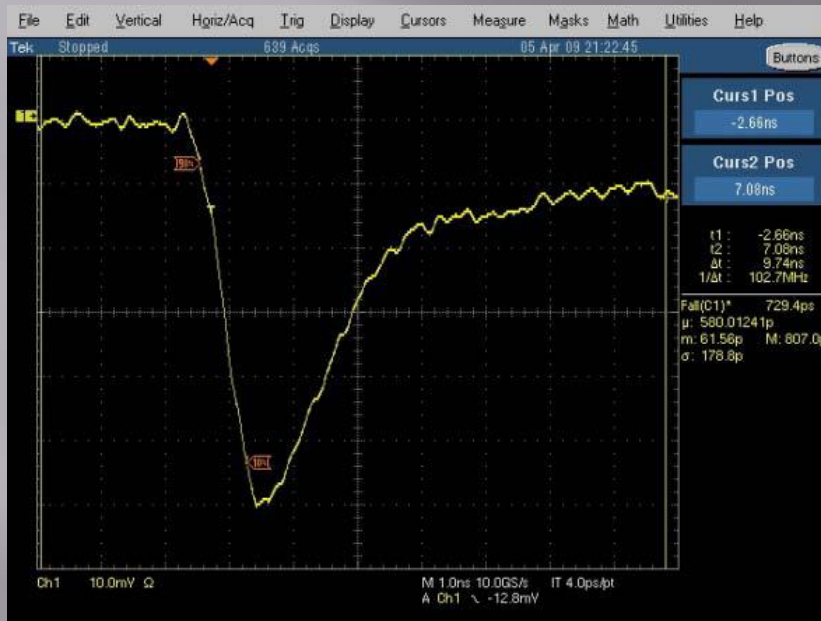
# SIPM сигналы

(b) S12571-050C (improved product)

( $M=1.25 \times 10^6$ )



# SIPM сигналы

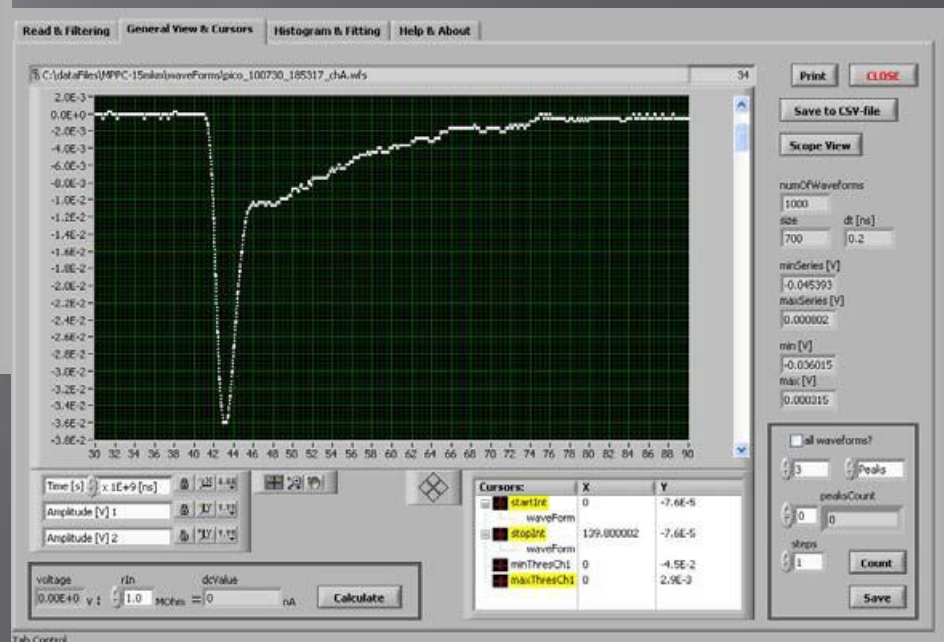
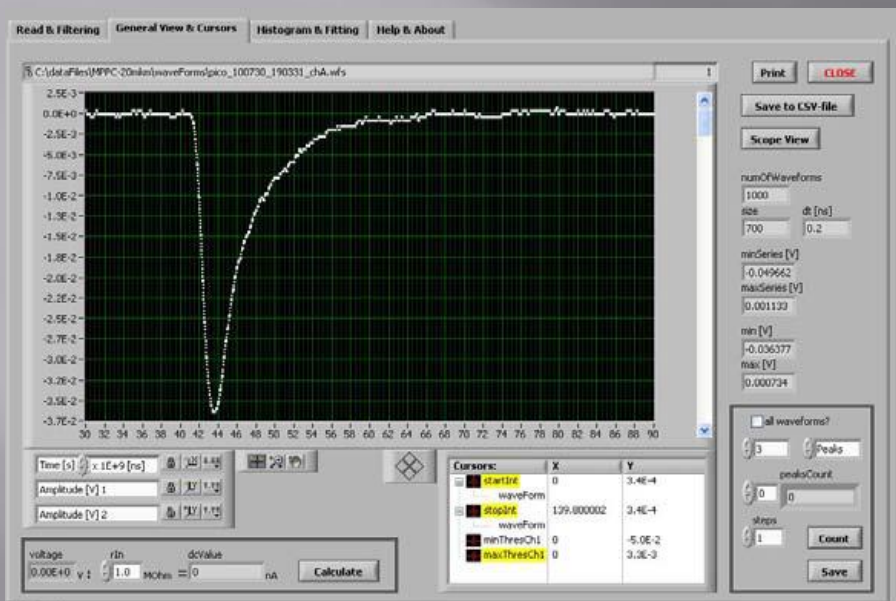


~700 psec rise time was measured (limited by circuitry)

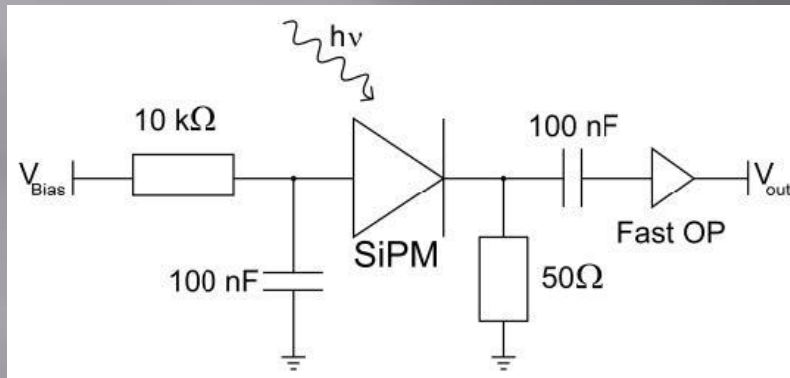
CPTA/Photonique1 mm<sup>2</sup>SSPM response  
to a 35 psecFWHM laser pulse ( $\lambda=635$  nm)

Zecotek3x3 mm<sup>2</sup>MAPD response to a 35  
psecFWHM laser pulse ( $\lambda=635$  nm)

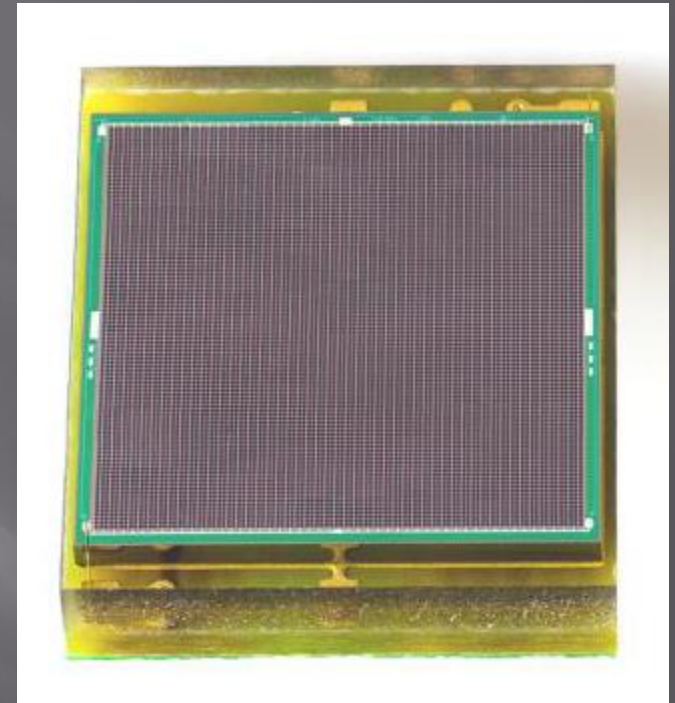
# SIPM сигналы



# SiPM включение

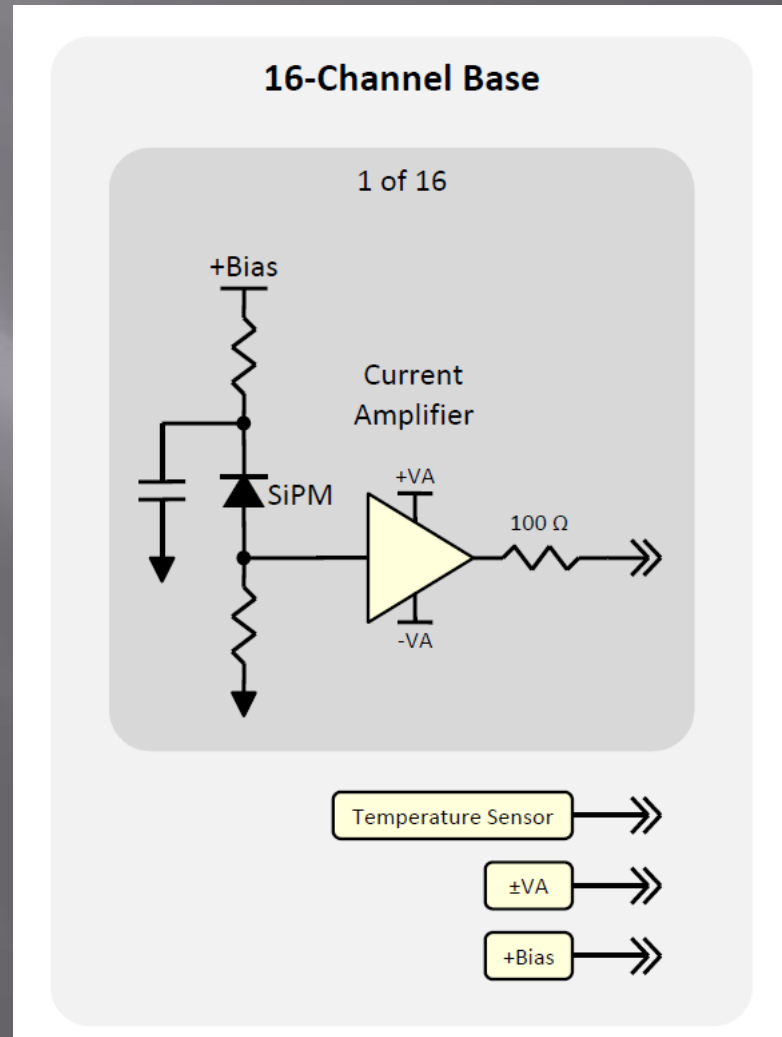


Example for Read Out  
Circuit  
PM6660



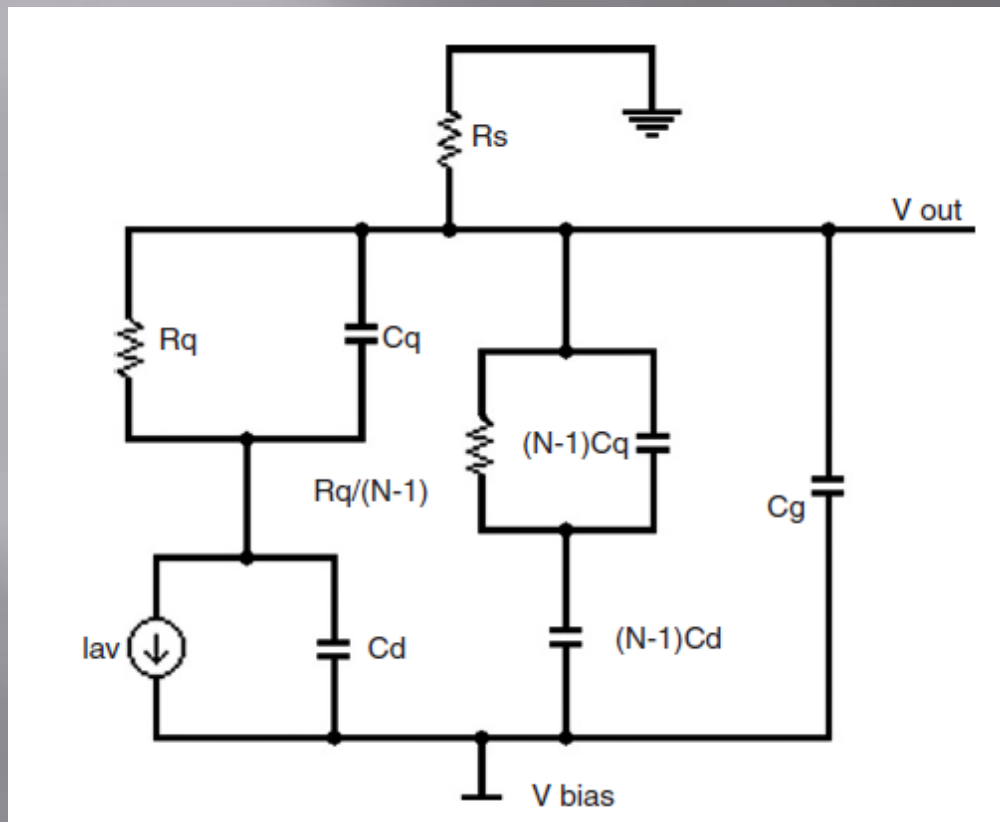
# SIPM ВКЛЮЧЕНИЕ

Example for Read Out  
Circuit  
S11064





# SIPM модель



Modelization by Corsi et al [NIM A572 2007]

# SIPM модель

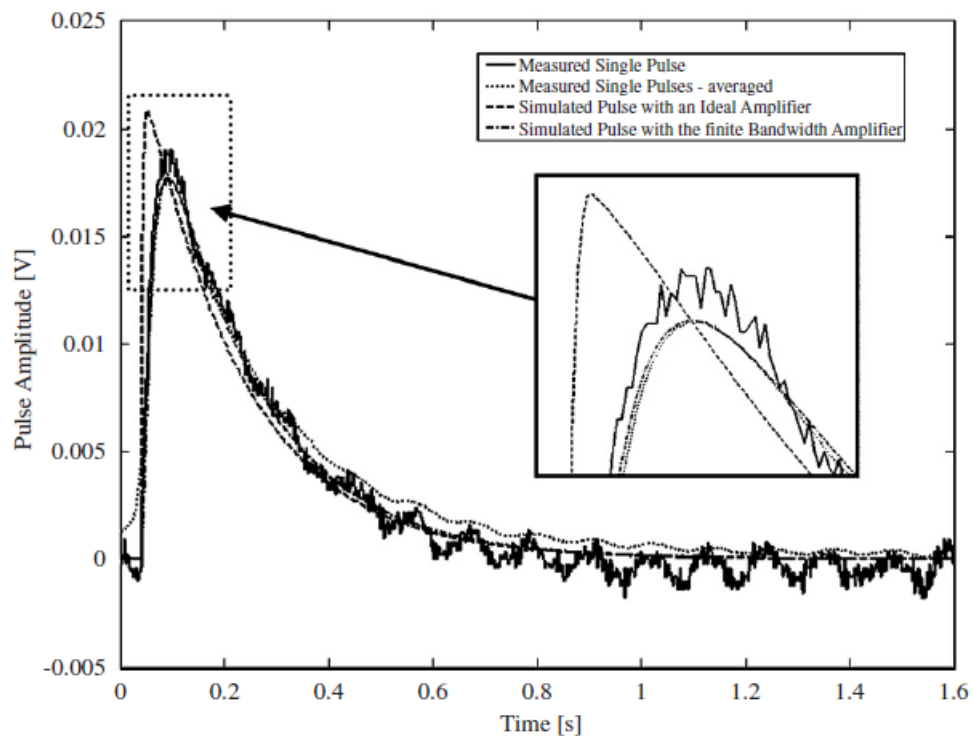
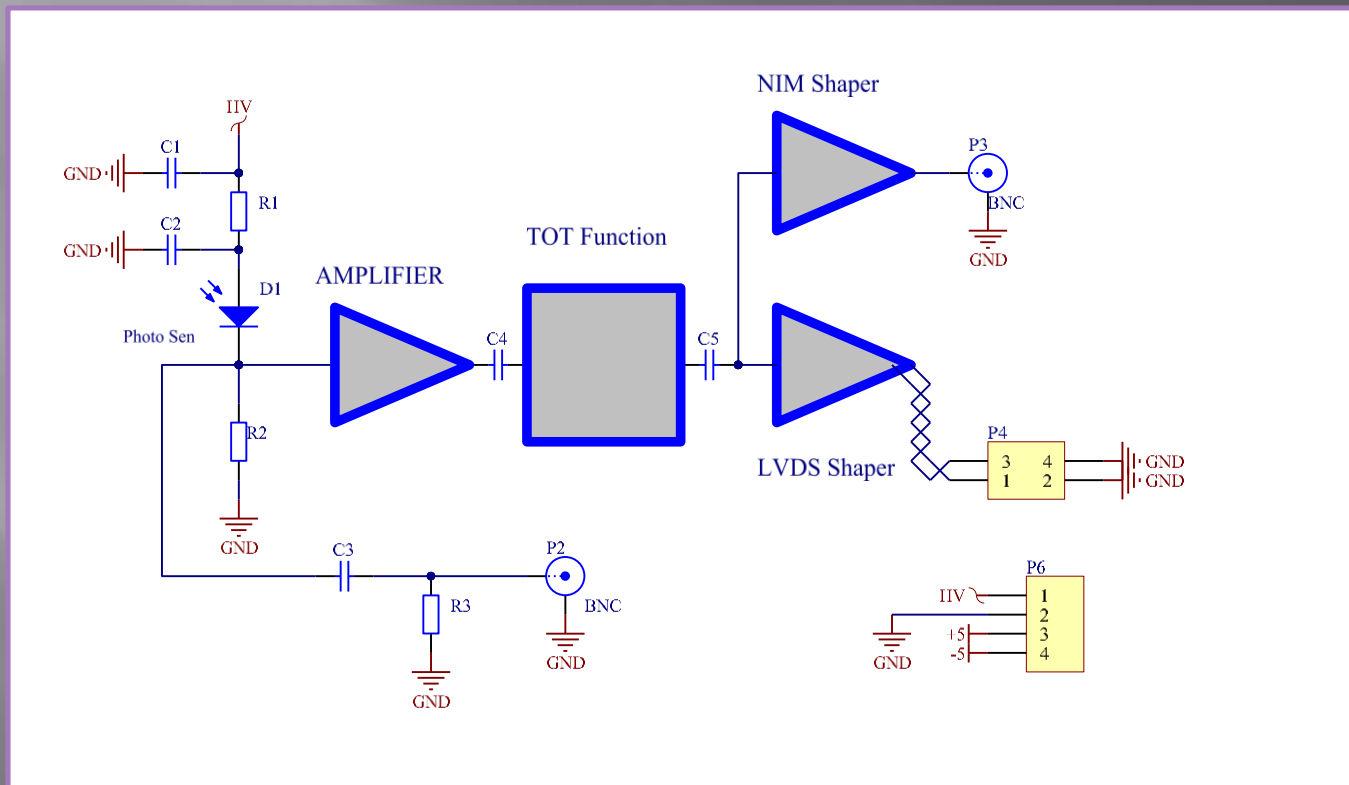
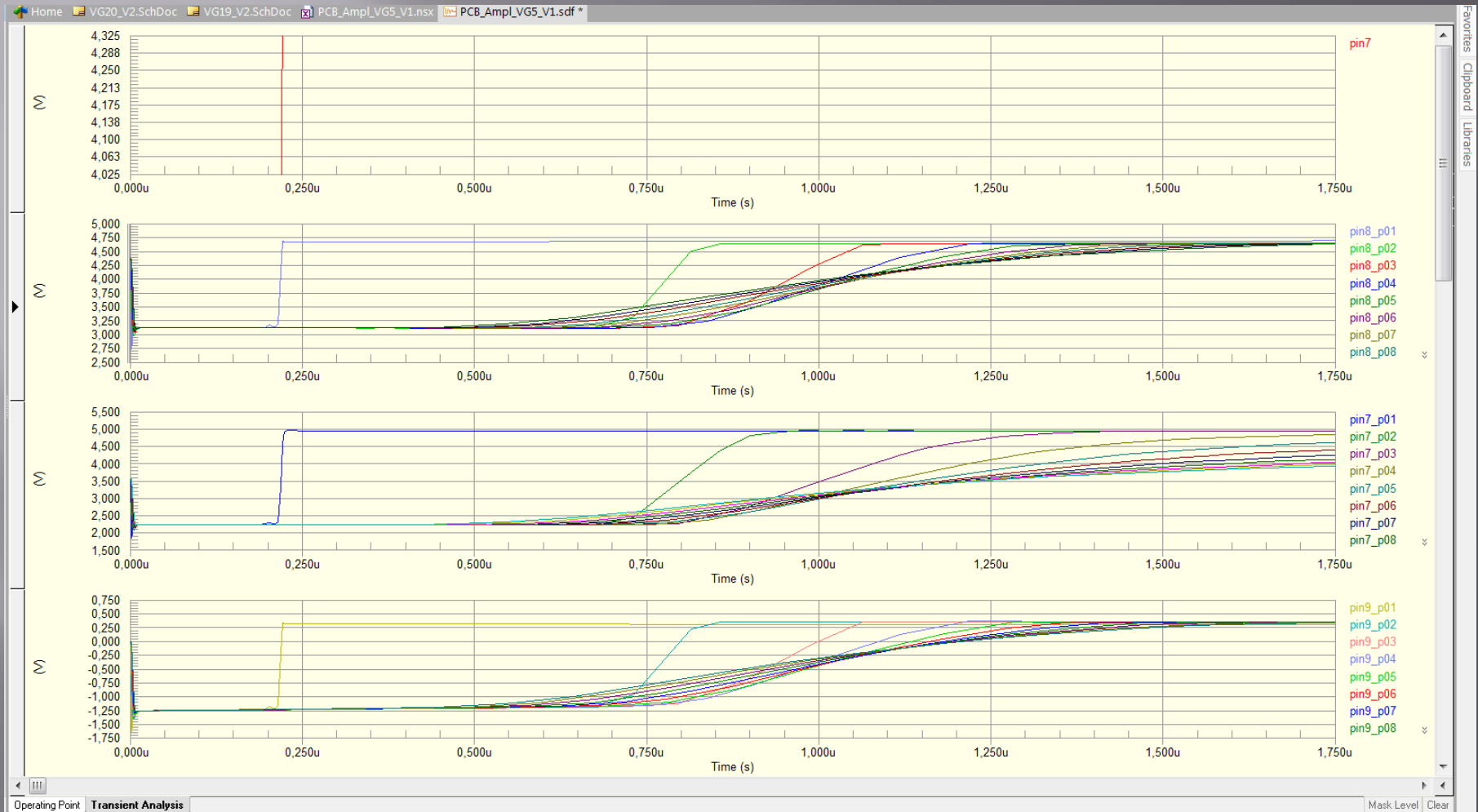


Fig. 2. Fitting of real data with the simulation results on the device model.

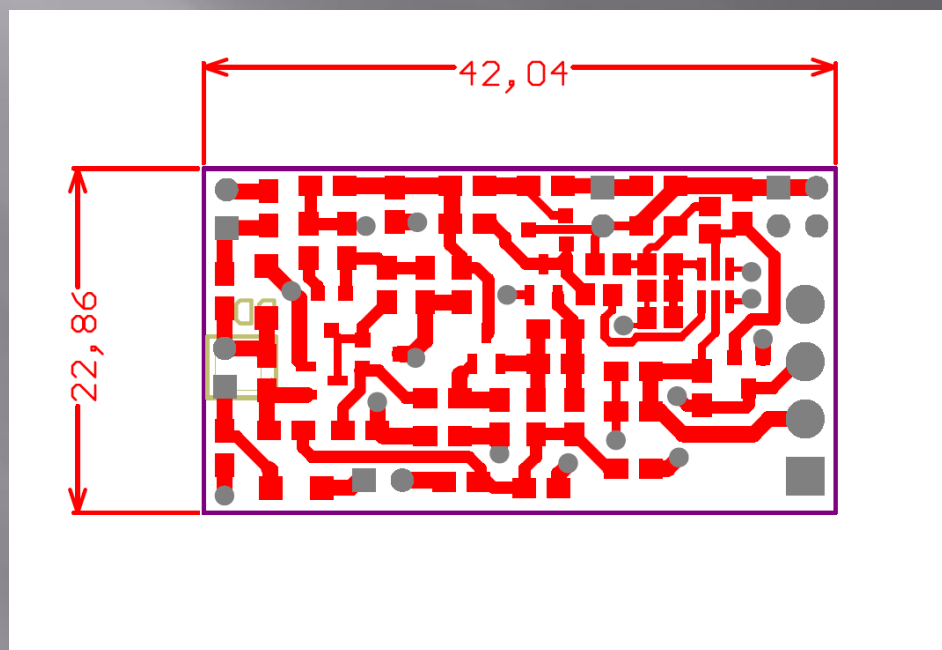
# Схема предусилителя



# Моделирование

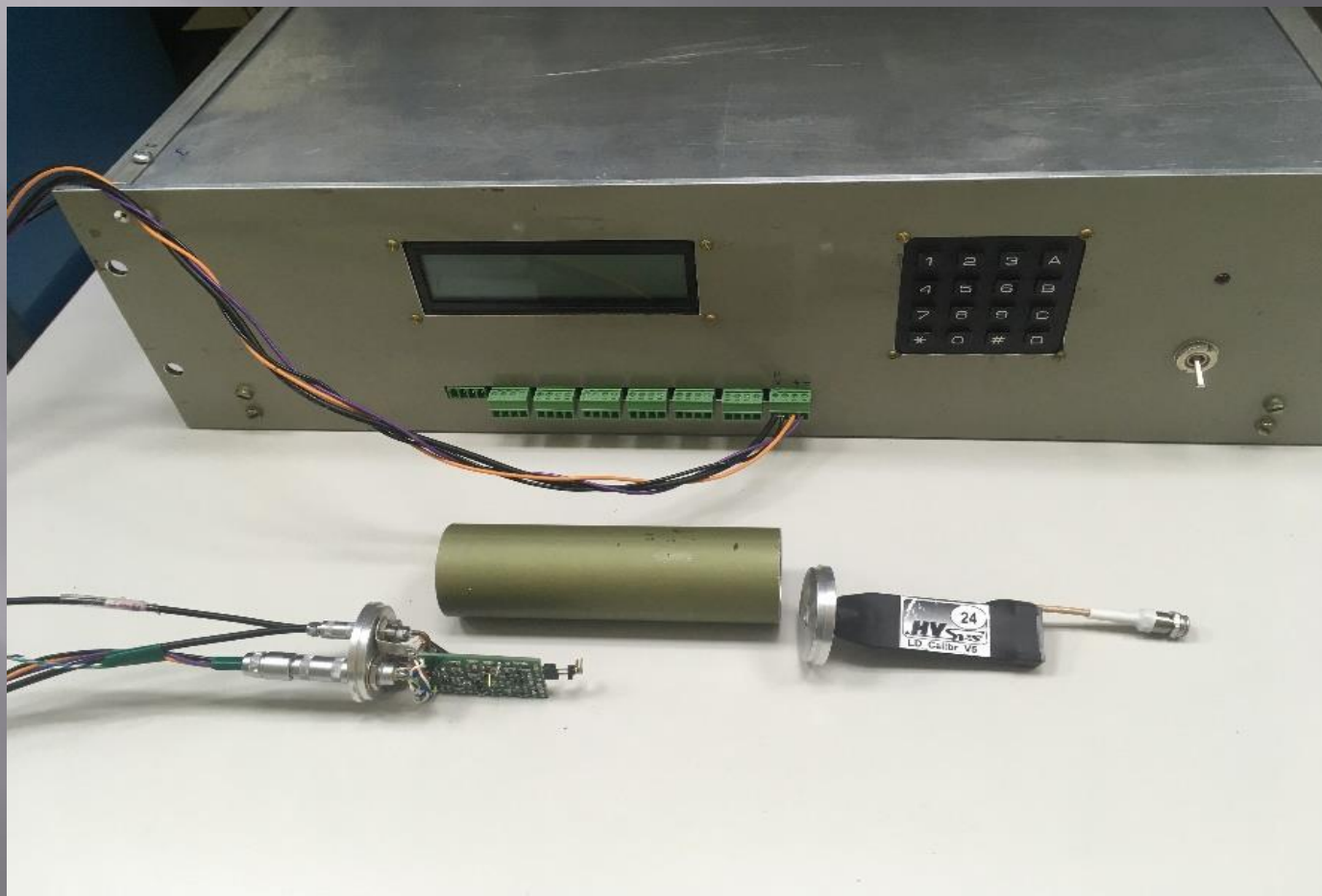


# Плата Предусилителя

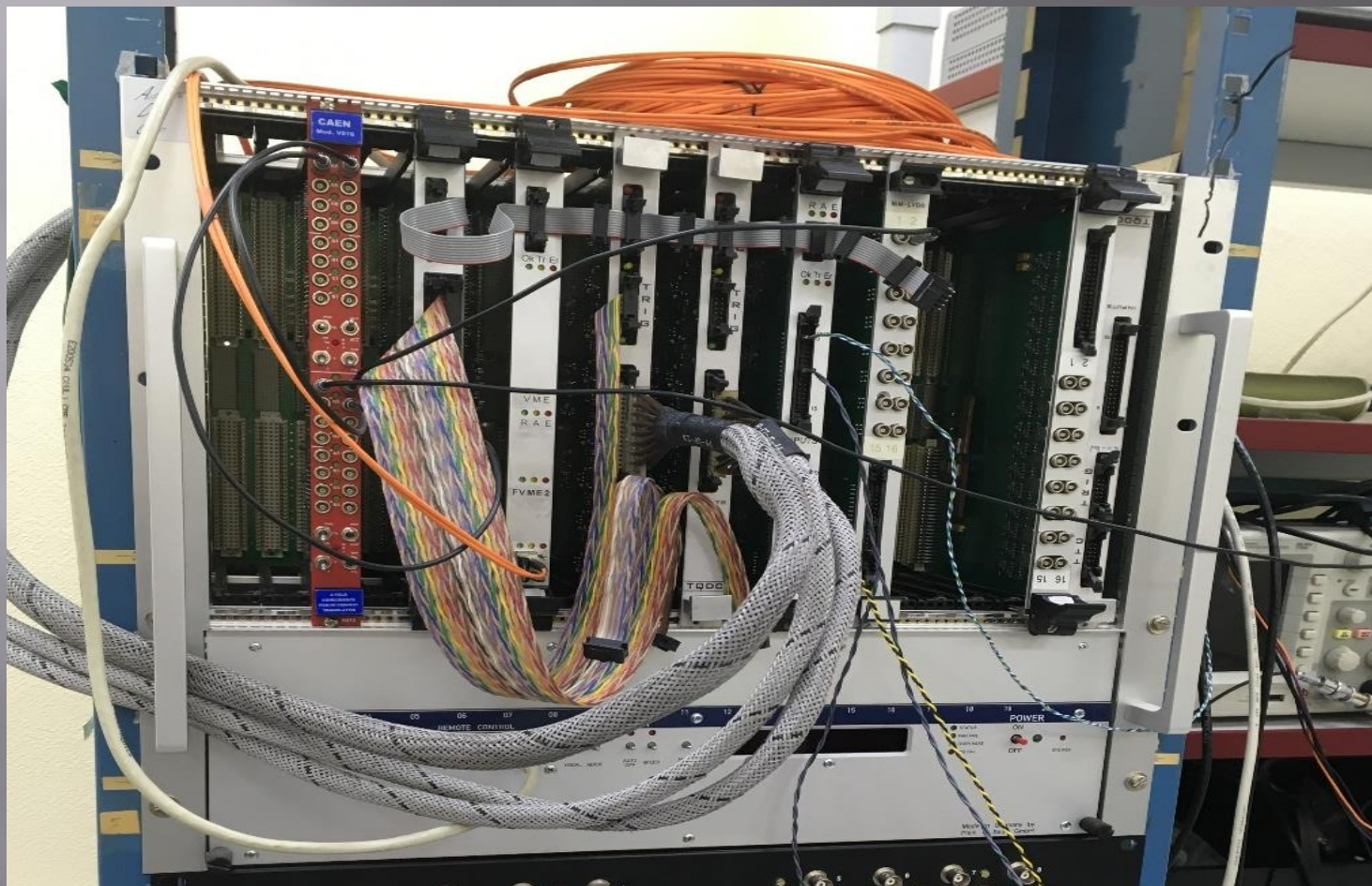


Размер в миллиметрах

# Усилитель и сервис

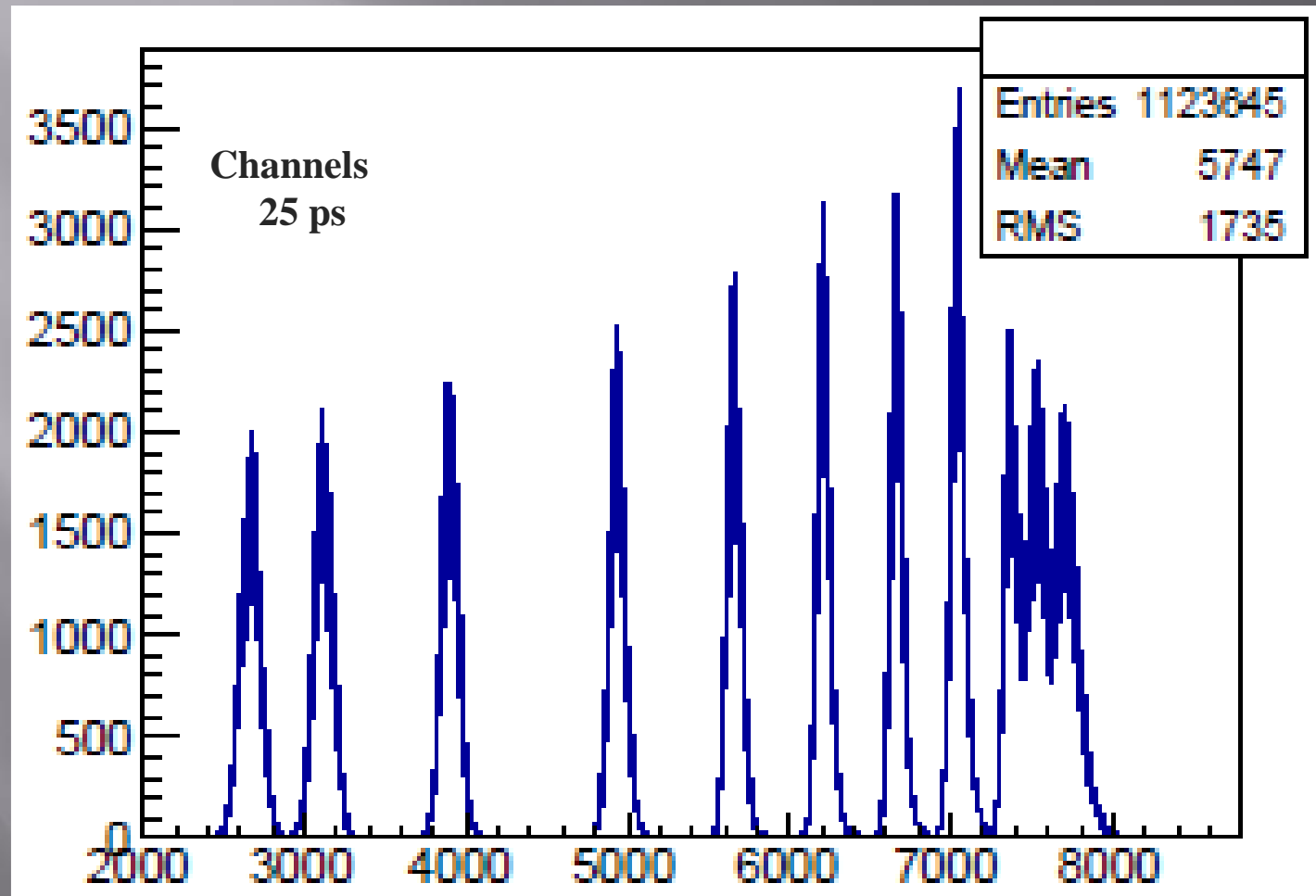


# Тест стенд



# Результат

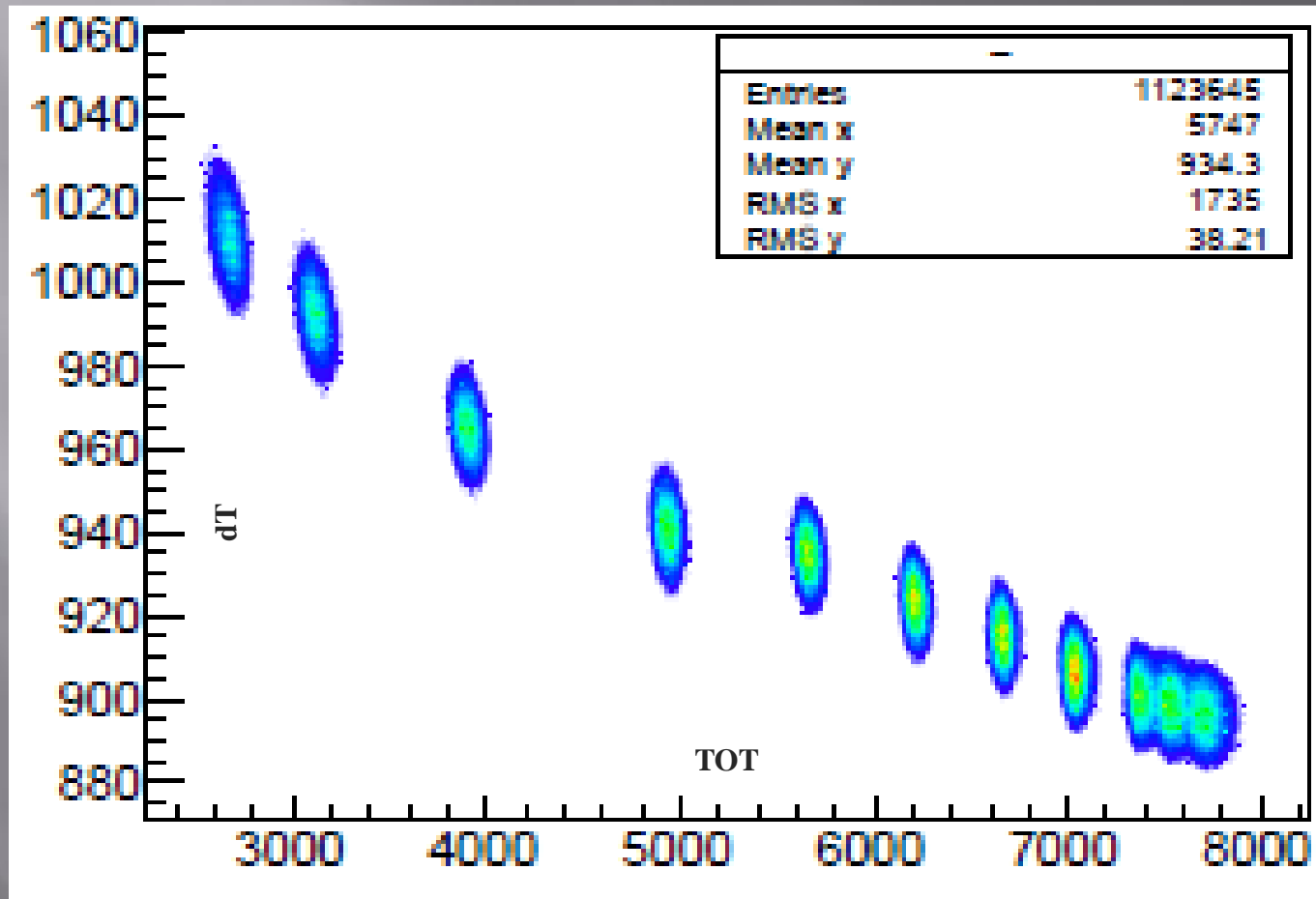
ТОТ





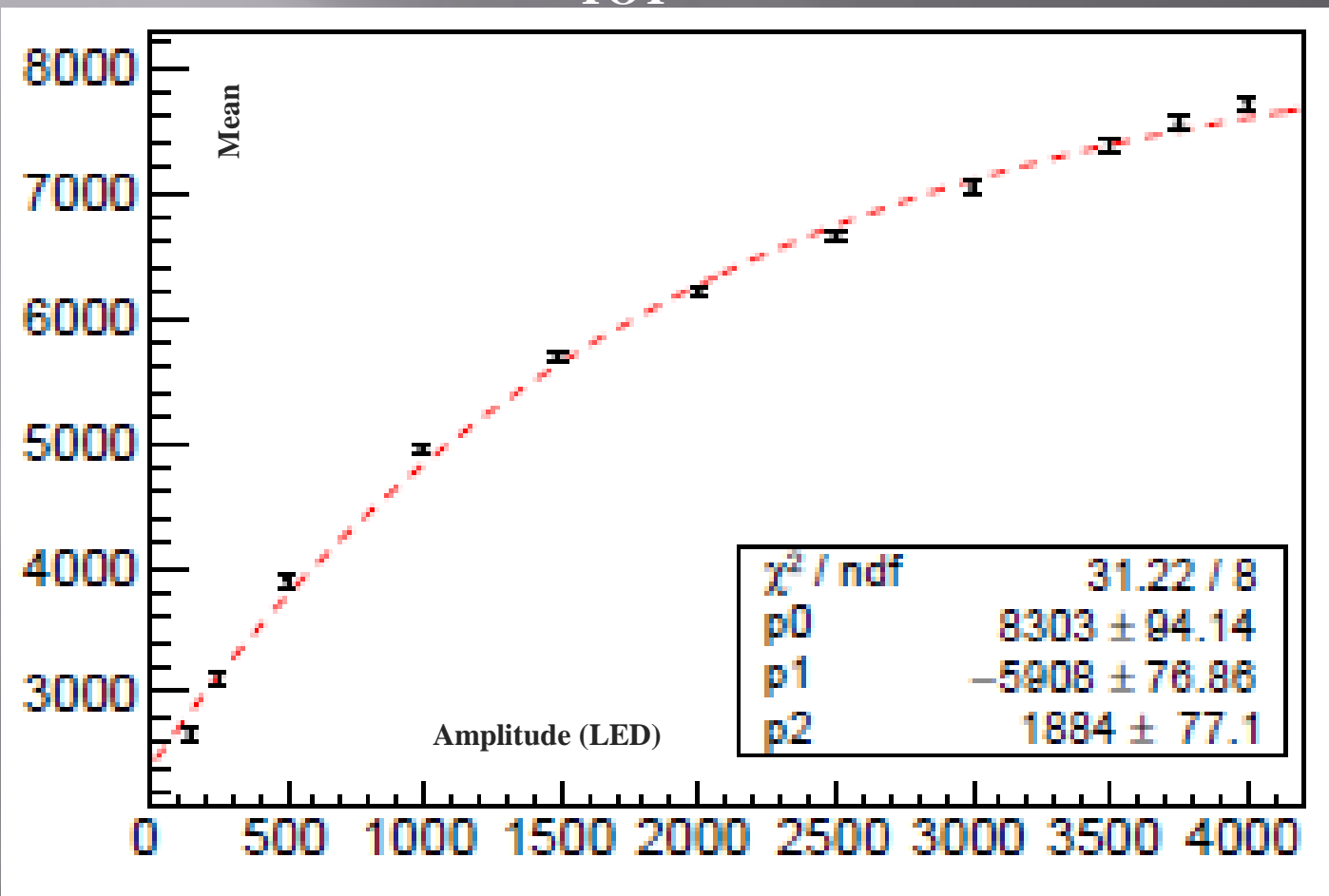
# Результат

Correlation dT/TOT



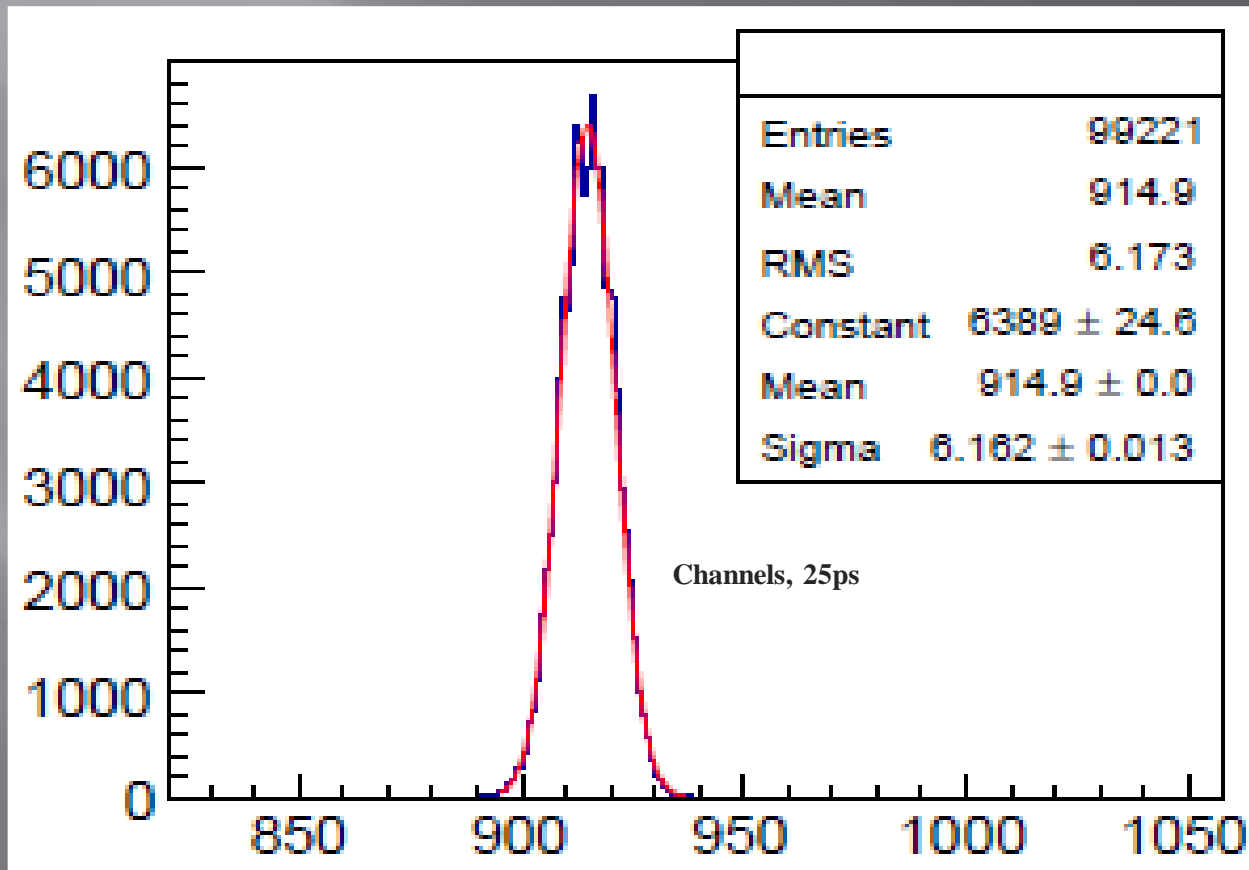
# Результат

ТОТ



# Результат

dT



# Заключение

- ▣ 1. Разработана схема предусилителя и изготовлены образцы.
- ▣ 2. Изготовлен модуль питания системы.
- ▣ 3. Проведены тесты.
- ▣ 4. Получена зависимость ТОТ.
- ▣ 6. Предварительно получено временное разрешение  $\sim 150\text{ps}$ .



СПАСИБО ЗА ВНИМАНИЕ !



Дубна 16.12.2019